Search Notes		

1	Application/Control No.	Applicant(s)/Patent under Reexamination	
Ŀ	10/814,781	TANNER, THOMAS	
Π	Examiner	Art Unit	
	Alan S. Chen	2182	

·	SEARCHED				
Class	Subclass	Date	Examiner		
710	30	9/25/2006	ASC		
	60				
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725	90				
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INTERFERENCE SEARCHED				
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(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT Inventor Search	9/25/2006	ASC